

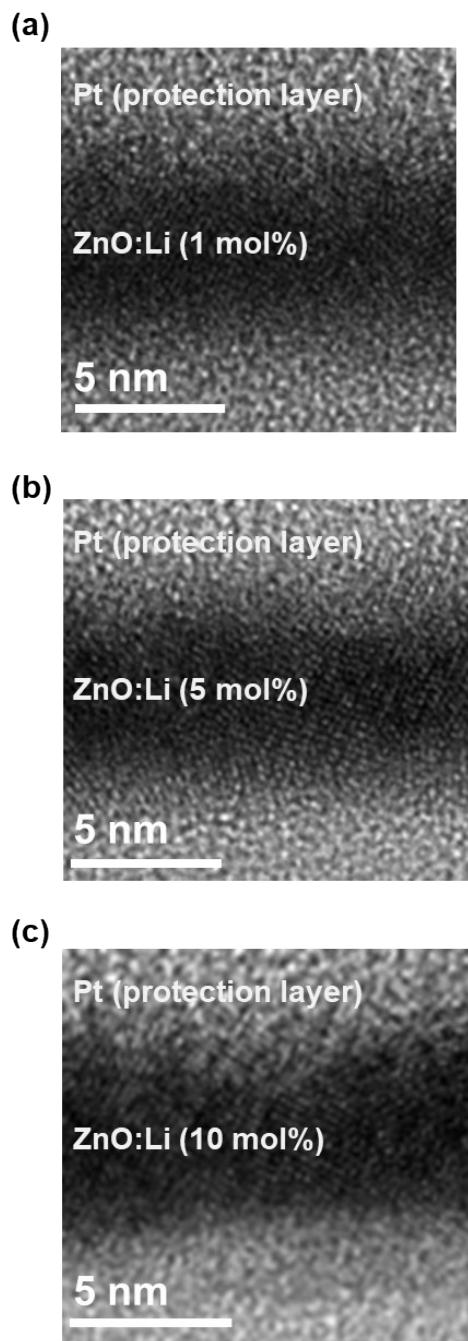
**Supplementary Information for:**

Improving visible-light photoresponse characteristics of  
ZnO phototransistor via solution processable Li dopants

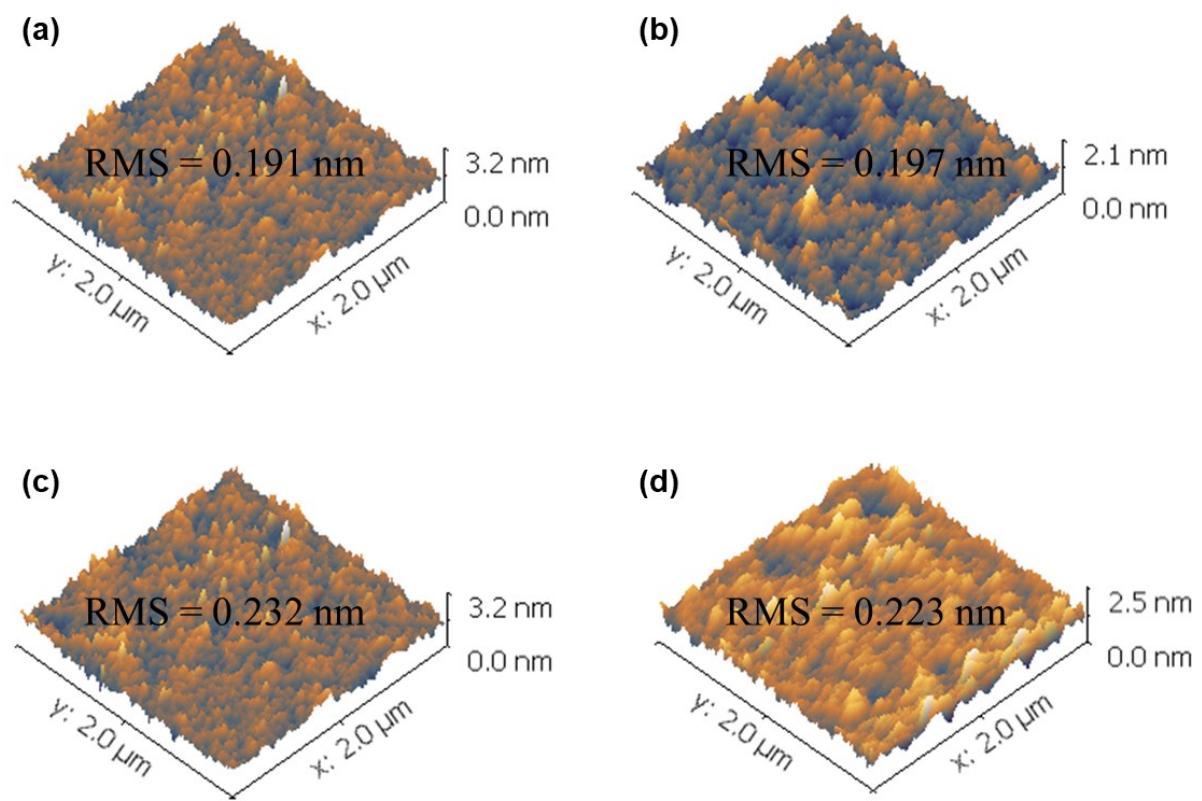
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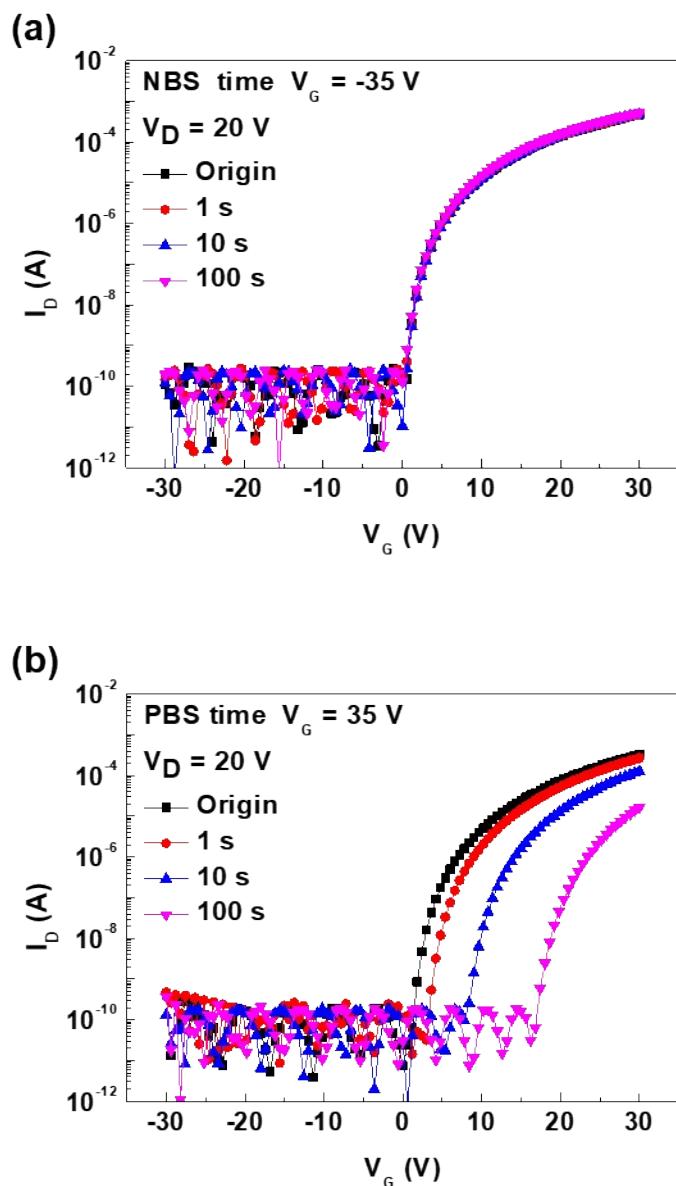
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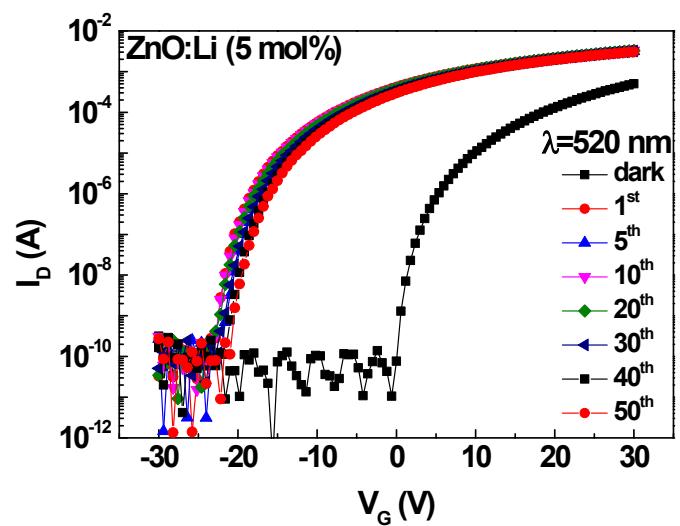
**Figure S1.** Cross-sectional high-resolution TEM images of a) ZnO:Li (1 mol%), b) ZnO:Li (5 mol%), and c) ZnO:Li (10 mol%) films.



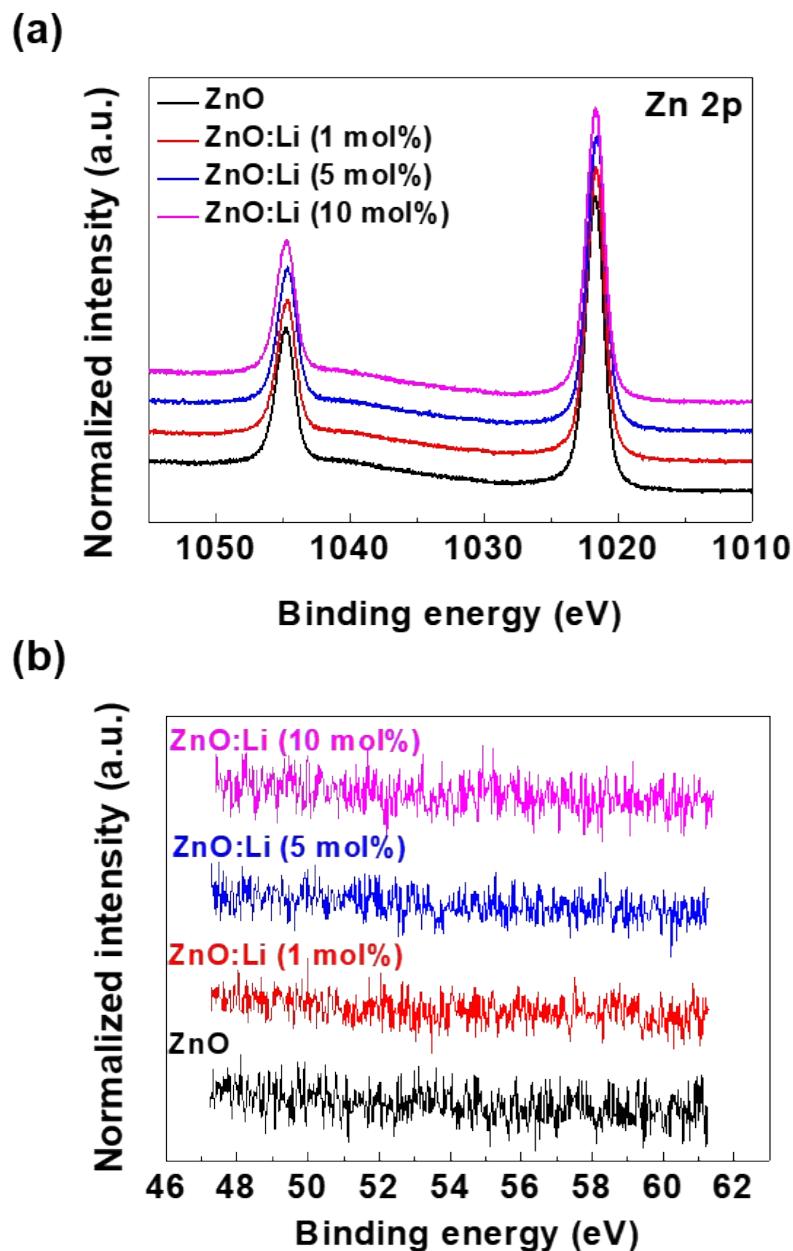
**Figure S2.** AFM images and root mean square (RMS) values of a) ZnO, b) ZnO:Li (1 mol%), c) ZnO:Li (5 mol%), and d) ZnO:Li (10 mol%).



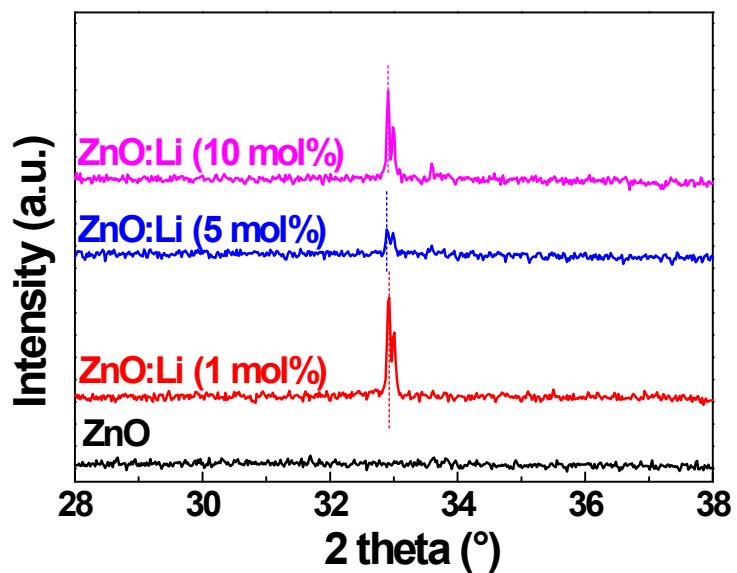
**Figure S3.** a) NBS at  $V_G = -35$  V on the ZnO:Li (5 mol%) TFT. b) PBS at  $V_G = 35$  V on the ZnO:Li (5 mol%) TFT.



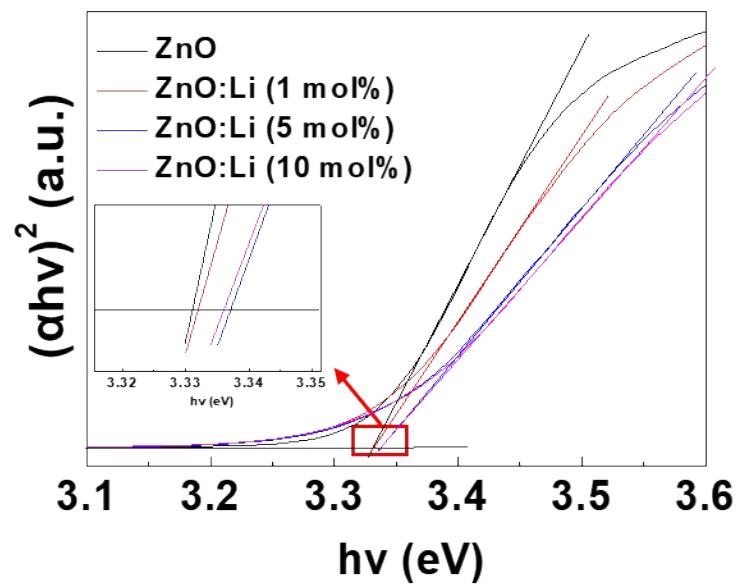
**Figure S4.** Transfer curve of ZnO:Li (5 mol%) TFT measured 50 times under 520 nm wavelength light exposure.



**Figure S5.** XPS spectra of a) Zn 2p and b) Li 1s of ZnO, ZnO:Li (1 mol%), ZnO:Li (5 mol%), and ZnO:Li (10 mol%) films, respectively.



**Figure S6.** XRD spectra of ZnO, ZnO:Li (1 mol%), ZnO:Li (5 mol%), and ZnO:Li (10 mol%) films.



**Figure S7.** Tauc's plots of ZnO, ZnO:Li (1 mol%), ZnO:Li (5 mol%), and ZnO:Li (10 mol%) films.

	2θ (°)
ZnO	-
ZnO:Li (1 mol%)	32.93
ZnO:Li (5 mol%)	32.89
ZnO:Li (10 mol%)	32.91

**Table S1.** XRD peaks(2θ) of (100) plane of ZnO, ZnO:Li (1 mol%), ZnO:Li (5 mol%), and ZnO:Li (10 mol%) films.